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MOS INTEGRATED CIRCUIT $\mu PD75P218$

4-BIT SINGLE-CHIP MICROCOMPUTER

The μ PD75P218 is a one-time PROM version that can be written to only once or an EPROM version that allows program writing, erasing, and rewriting, of the μ PD75218 ^{Note}.

Since the program can be written by the user, the μ PD75P218 is suitable for preproduction use during system development, or limited production.

Read this material together with the μ PD75218 materials.

Note Under development

FEATURES

- µPD75218 compatible
- On-chip 16K-byte mode/32K-byte mode switching function
- Operates at the same power supply voltage range (2.7 to 6.0 V) as the mask ROM version μ PD75218.
- 32640×8 bits of PROM
- 1024 × 4 bits of RAM
- No pull-down resistor for Port 6
- High breakdown voltage display output
 - S0 to S8, T0 to T9: On-chip pull-down resistor
 - S9, T10 to T15 : Open drain
- No power-on reset circuit

Caution No mask-option pull-down resistor is provided.

ORDERING INFORMATION

Part Number	Part Number Package	
μPD75P218CW	64-pin plastic shrink DIP (750 mil)	Standard
μ PD75P218GF-3BR	64-pin plastic QFP (14 $ imes$ 20 mm)	Standard
μ PD75P218KB	64-pin ceramic LCC with window (14 $ imes$ 20 mm)	Standard

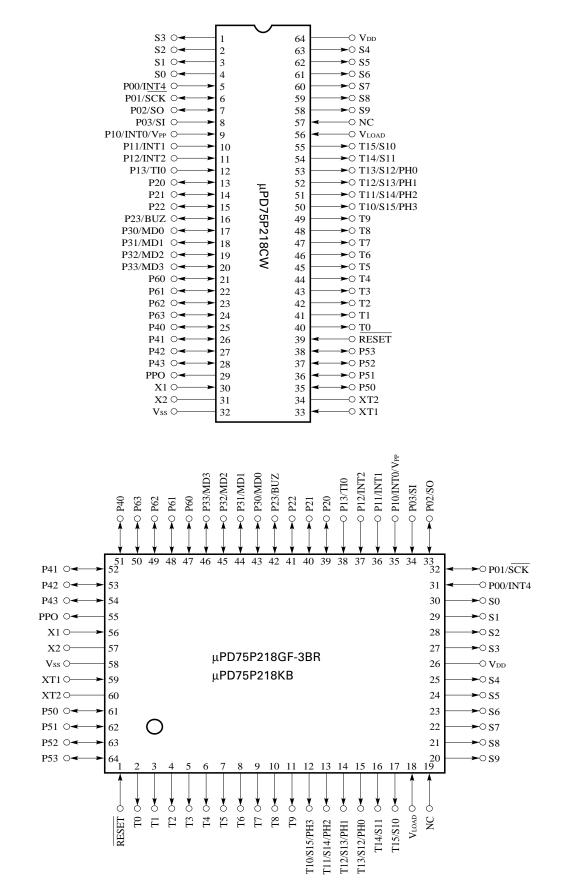
Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

The word "PROM" in this document refers to the common parts of the one-time PROM products and EPROM products.

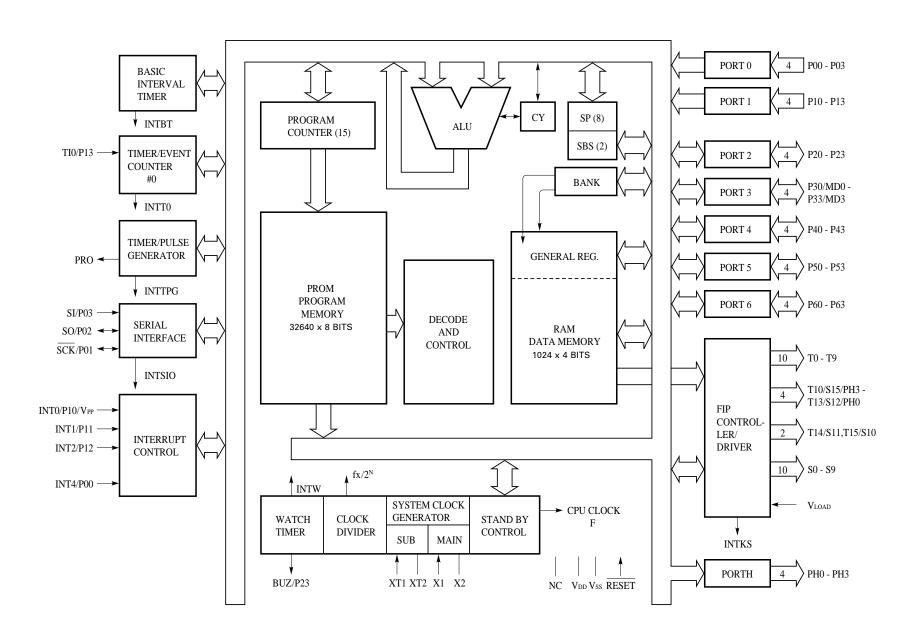
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Phase-out/Discontinued

PIN CONFIGURATION (Top View)



Phase-out/Discontinued



BLOCK DIAGRAM

 μ PD75P218



1. PIN FUNCTIONS

1.1 PORT PINS

Pin name	Input/ output	Shared pin	Fun	ction	8-bit I/O	When reset
P00	Input	INT4	4-bit input port (PORT0).	4-bit input port (PORT0).		Input
P01	I/O	SCK				
P02	I/O	SO				
P03	Input	SI				
P10	Input	INT0/Vpp	4-bit input port (PORT1).	With noise elimination		Input
P11		INT1		function		
P12		INT2				
P13		TIO				
P20	I/O	-	4-bit I/O port (PORT2).		×	Input
P21	1	-				
P22		-				
P23	1	BUZ				
P30 - P33	I/O	MD0 - MD3	Programmable 4-bit I/O port (PORT3). I/O can be specified bit by bit.			Input
P40 - P43	I/O	_	4-bit I/O port (PORT4). Can directly drive LEDs.	Data input/output pins for the PROM write and verify (Four low-order bits).	0	Input
P50 - P53	I/O	_	4-bit I/O port (PORT5). Can directly drive LEDs.	Data input/output pins for the PROM write and verify (Four high-order bits).	_	Input
P60 - P63	I/O	-	Programmable 4-bit I/O port (PORT6). I/O can be specified bit by bit. Suitable for key input.		×	Input
PH0	Output	T13/S12	4-bit P-ch open drain high		×	High
PH1		T12/S13	current output port (PORTI	H).		impedance
PH2		T11/S14	Can directly drive LEDs.			
PH3		T10/S15				

1.2 NON-PORT PINS

Pin name	Input/ output	Shared pin		Function	When reset	
T0 - T9		_	Note 1	Note 1 High breakdown voltage large current output pin for digit output		
T10/S15 - T13/S12	Output	PH3 - PH0	Note 2	Note 2High breakdown voltage large current output pin for digit/segment outputThe remainder of the pins can be used as PORTH.		
T14/S11, T15/S10		_		High breakdown voltage large current output pin for digit/segment output Static output is also available.		
S9				High breakdown voltage output pin for segment output Static output is also available.		
S0 - S8			Note 1	High breakdown voltage output pin for segment output	Low level	
PPO	Output	-	Output fo	or receiving pulse signal for timer/pulse generator	High impedance	
TIO	Input	P13		nput for receiving external event pulse signal for timer/ vent counter		
SCK	I/O	P01	Serial clo	Serial clock I/O		
SO	I/O	P02	Serial data output or serial data I/O		Input	
SI	Input	P03	Serial da	Serial data input or normal input		
INT4	Input	P00	-	Edge detection vectored interrupt input either rising edge or falling edge detection)		
INT0	Input	P10/VPP	Edge det	dge detection vectored interrupt input with noise elimination		
INT1		P11	(detection	detection edge selectable)		
INT2	Input	P12	Edge det	dge detection testable input (rising edge detection)		
BUZ	I/O	P23	Fixed free	Fixed frequency output pin (for buzzer or system clock trimming)		
X1, X2		-	generatio When ex	Crystal/ceramic resonator connection for main system clock generation. When external clock is used, it is applied to X1, and its reserve phase signal is applied to X2.		
XT1, XT2		-		Crystal connection for subsystem clock generation. When external clock is used, it is applied to XT1, and XT2 is open.		
RESET	Input	-	System r	eset input (low level active)		
MD0 - MD3	I/O	P30 - P33	Operation	Operation mode selection pins during the PROM write/verify cycles		
Vpp		P10/INT0		+12.5 V is applied as the programming voltage during the PROM write/verify cycles		
VLOAD		-	Pull-dow	Pull-down resistor connection pin of FIP [®] controller/driver		
Vdd		-		Positive power supply. +6 V is applied as the programming voltage during the PROM write/verify cycles		
Vss		_	GND pot	GND potential		
NC Note 3		_	No conne	ection		

Note 1. On-chip pull-down resistor

- 2. Open drain output
- 3. When using a printed board with a μ PD75216A, 75217, or 75218, connect the NC pin to the VPRE.

1.3 PIN INPUT/OUTPUT CIRCUITS

The input/output circuit diagram for each μ PD75P218 pin is shown in Fig. 1-1 in a simplified manner. For the correspondence of the each pin and input/output type number, refer to Table 1-1.

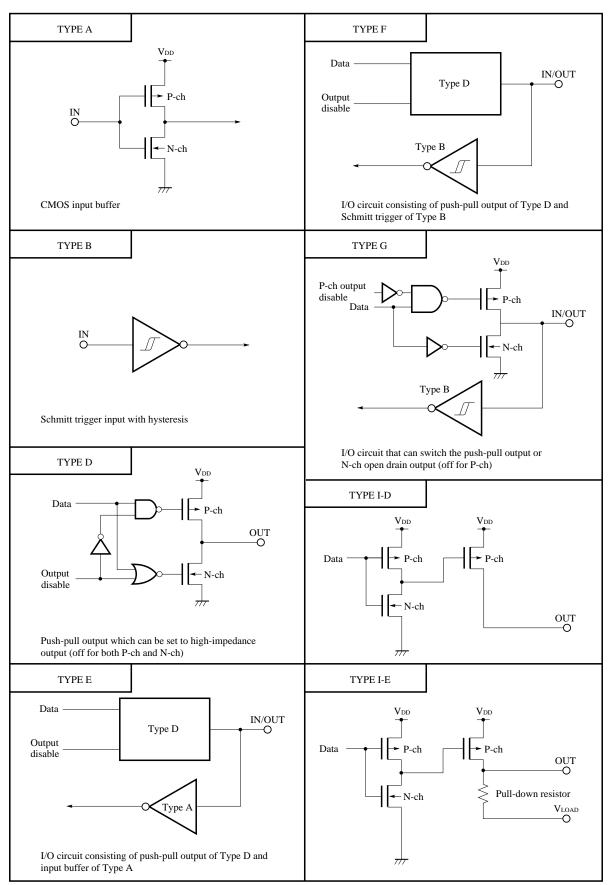
Pin name	I/O type	Pin name	I/O type
P00/INT4	B	P50 - P53	E
P01/SCK	Ð	P60 - P63	E
P02/SO	G	Т0 - Т9	I-E
P03 - SI	B	T10/S15/PH3 - T13/S12/PH0	I-D
P10/INT0/VPP	B	T14/S11, T15/S10	I-D
P11/INT1, P12/INT2		S0 - S8	I-E
P13 - TI0		S9	I-D
P20 - P22	E	PPO	D
P23/BUZ		RESET	B
P30/MD0 - P33/MD3	E	VLOAD	I-E
P40 - P43	E		

Table 1-1 Pins and Input/Output Type Numbers

Remark I/O type enclosed with a circle indicates Schmitt triggered input.

Phase-out/Discontinued

Fig. 1-1 Pin Input/Output Circuit





1.4 PROCESSING OF UNUSED PINS

Table 1-2 Recommended Connection of Unused Pins

Pin name	Recommended connection
P00/INT4	Connect to Vss
P01/SCK	Connect to Vss or VDD
P02/SO	
P03/SI	
P10/INT0/VPP	Connect to Vss
P11/INT1, P12/INT2	
P13/T10	
P20 - P22	Input state: Connect to Vss or VDD
P23/BUZ	Output state: Open
P30/MD0 - P33/MD3	
P40 - P43	
P50 - P53	
P60 - P63	
РРО	Open
S0 - S9	
T15/S10, T14/S11	
Т0 - Т9	
T10/S15/PH3 - T13/S12/PH0	
XT1	Connect to Vss or VDD
XT2	Open
VLOAD when no on-chip load resistor	Connect to Vss or VDD



2. DIFFERENCES BETWEEN THE μ PD75P218 AND THE μ PD75P216A, 75217, 75218

ltem	Part number Item		μPD75217	μPD75218 Note	μPD75P218	
ROM		One-time PROM 16K × 8	Mask ROM 24K × 8	Mask ROM 32K × 8	PROM 32K × 8	
RAM		512 × 4	768 × 4	1024	4 × 4	
FIP control-	segments		9 - 16 se	egments		
ler/driver	digits		9 - 16	digits		
Pull-down	P60 - P63	Not available	Mask-	option	Not available	
resistors	S0 - S8, T0 - T9	On-chip	Mask-	option	On-chip	
	SD9, T10 - T15	Not available (open drain)			Not available (open drain)	
Pin connec- tion	P10	INT0/V _{PP} (common use)	INT0 (common use)		INT0/V _{PP} (common use)	
	P30 - P33	MD0 - MD3 (common use)	No common use		MD0 - MD3 (common use)	
	VPRE	Not available (NC)	Available		Not available (NC)	
Operating amb ture	pient tempera-	–10 to +70 °C	−40 to +85 °C		–40 to +70 °C	
Power supply	voltage	5 V ± 10 %		2.7 - 6.0 V	I	
Stack area		Bank 0	Bank 0 - 2	Bank	k 0 - 3	
16K-byte mode/32K-byte mode switching function		Not available		Available		
Package		64-pin plastic shrink DIP	64-pin plastic shrink DIP 64-pin plastic QFP		64-pin plastic shrink DIP 64-pin plastic QFP 64-pin ceramic LCC with window	

Note Under development

3. 16K-BYTE MODE/32K-BYTE MODE SWITCHING FUNCTION

16K-byte mode or 32K-byte mode can be selected by setting the stack bank selection register (SBS). The μ PD75P218 can then be used to evaluate the μ PD75216A, μ PD75217, and μ PD75218.

3.1 DIFFERENCES BETWEEN 16K-BYTE MODE AND 32K-BYTE MODE

Table 3-1 16K-byte Mode and 32K-byte Mode Differences

ltem	16K-byte Mode	32K-byte Mode
Stack operation at subroutine call instruction execution	2-byte stack	3-byte stack
Stack area	Bank 0	Bank 0 to bank 3
CALL instruction	3 machine cycles	4 machine cycles
TCALL instruction by GETI		
CALLF instruction	2 machine cycles	3 machine cycles
BRA instruction	Undefined operation	Normal operation
CALLA instruction		
Program counter bit 14	0 fixed	Corresponds to branch instruction, call instruction
Corresponding mask ROM version	μPD75216A (S-DIP, QFP)	μPD75217 (S-DIP, QFP) μPD75218 (S-DIP, QFP)



3.2 16K-BYTE MODE AND 32K-BYTE MODE SWITCHING

16K-byte mode and 32K-byte mode are switched by the stack bank selection register. The stack bank selection register format is shown in Fig. 3-1.

The stack bank selection register is set by 4-bit memory manipulation instruction. RESET input sets bit 3 of the stack bank selection register to "1" and changes from 32K-byte mode to 16K-byte mode. When 16K-byte mode is used, manipulating the stack bank selection register is unnecessary. When 32K-byte mode is used, the stack bank selection register must always be initialized to 00××B Note 1 at the beginning of the program.

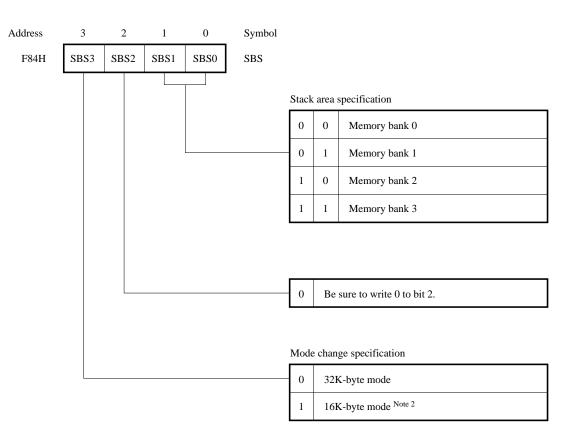


Fig. 3-1 Stack Bank Selection Register Format

- Caution When using 32K-byte mode, execute a subroutine call instruction and an interrupt enable instruction after the stack bank selection register is set after RESET input.
- Notes 1. Set the desired value in $\times\!\!\times$.
 - **2.** When the 16K-byte mode is used after RESET input, the stack bank selection register does not have to be manipulated.

4. PROM (PROGRAM MEMORY) WRITE AND VERIFY

The PROM contained in the μ PD75P218 is one-time PROM or EPROM for writing, erasing, and rewriting. Table 4-1 shows the pin functions during the write and verify cycles. Note that it is not necessary to enter an address, because the address is updated by pulsing the X1 clock pins.

Table 4-1 PROM Write and Verify Pin Functions

Pin Name	Function
Vpp	Normally 2.7 to 6 V; 12.5 V is applied during the write/verify cycles.
X1, X2	After a write/verify write, the X1 and X2 clock pins are pulsed. The inverted signal of the X1 should be input to the X2. Note that these pins are also pulsed during a read.
MD0 - MD3	Operation mode selection pins during the write/verify cycles
P40 - P43 (Four low-order bits) P50 - P53 (Four high-order bits)	8-bit data input/output pins during the write/verify cycles
V _{DD}	Supply voltage
	Normally 2.7 to 6 V; 6 V is applied during the write/verify cycles.

Cautions 1. The pins not used for write and verify should be processed as follows.

XT2	Open
RESET, PPO, VLOAD	
	Connect to GND (directly connectable)
Port 0 - 2, Port 6, XT1]	

- 2. An opaque film should be placed over the UV erase window of the μ PD75P218KB except when erasing the EPROM contents.
- 3. The μ PD75P218CW/GF does not have a UV erase window, thus the PROM contents cannot be erased with ultraviolet ray.

4.1 PROM WRITE AND VERIFY OPERATION

When +6 V and +12.5 V are applied to the V_{DD} and V_{PP} pins, respectively, the PROM is placed in the write/ verify mode. The operation is selected by the MD0 to MD3 pins, as shown in Table 4-2.

Operation Mode Specification			On another Martin				
Vpp	Vdd	MD0	MD1	MD2	MD3	Operation Mode	
+12.5 V	+6 V	Н	L	Н	L	Clear program memory address to 0	
		L	н	н	н	Write mode	
		L	L	н	Н	Verify mode	
		Н	×	Н	Н	Program inhibit	

Table 4-2 PROM Write and Verify Operation Mode

 \times : Don't care.

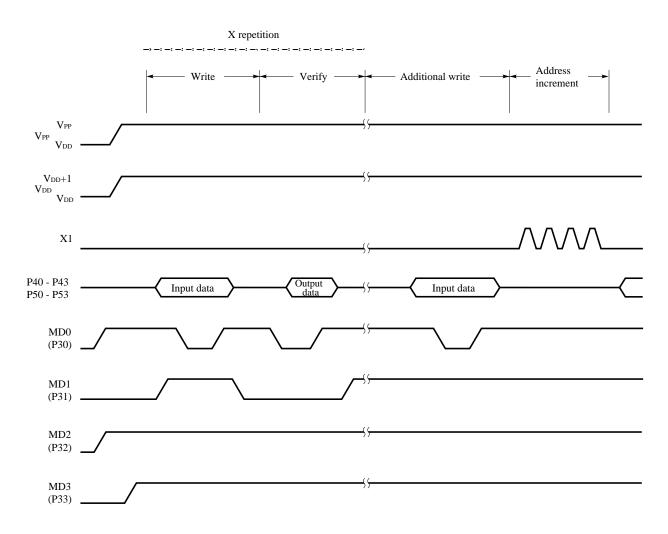


4.2 PROM WRITE/VERIFY PROCEDURE

PROMs can be written at high speed using the following procedure: (see the following figure)

- (1) Connect unused pins to Vss. Set the X1 pin low.
- (2) Supply 5 volts to the VDD and VPP pins.
- (3) Wait for 10 μ s.
- (4) Select the zero clear program memory address mode.
- (5) Supply 6 volts to the V_{DD} and 12.5 volts to the V_{PP} pins.
- (6) Select the program inhibit mode.
- (7) Write data in the 1 ms write mode.
- (8) Select the program inhibit mode.
- (9) Select the verify mode. If the data is correct, proceed to step (10). If not, repeat steps (7), (8) and (9).
- (10) Perform one additional write (duration of 1 ms \times number of writes at (7) to (9)).
- (11) Select the program inhibit mode.
- (12) Apply four pulses to the X1 pin to increment the program memory address by one.
- (13) Repeat steps (7) to (12) until the end address is reached.
- (14) Select the zero clear program memory address mode.
- (15) Return the VDD and VPP pins back to + 5 volts.
- (16) Turn off the power.

Fig. 4-1 PROM Write Timing



X: number of writes performed at (7) to (9)

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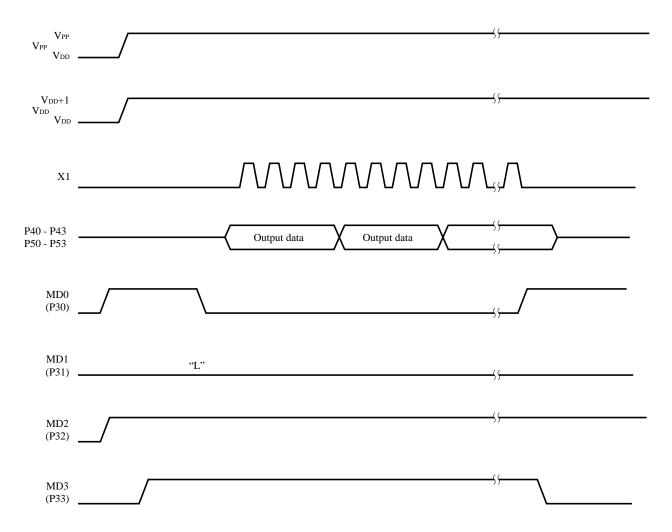


4.3 PROM READ PROCEDURE

The PROM contents can be read in the verify mode by using the following procedure: (see the following figure)

- (1) Connect unused pins to Vss. Set the X1 pin low.
- (2) Supply 5 volts to the V_DD and V_PP pins.
- (3) Wait for 10 μ s.
- (4) Select the clear program memory address mode.
- (5) Supply 6 volts to the V_DD and 12.5 volts to the V_PP pins.
- (6) Select the program inhibit mode.
- (7) Select the verify mode. Apply four pulses to the X1 pin. Every four clock pulses will output the data stored in one address.
- (8) Select the program inhibit mode.
- (9) Select the clear program memory address mode.
- (10) Return the V_{DD} and V_{PP} pins back to + 5 volts.
- (11) Turn off the power.





4.4 ERASING METHOD

The program data contents of the μ PD75P218KB are erased by lighting ultraviolet ray whose wavelength is about 250 nm on the window. The minimum amount of radiation exposure required to erase the contents completely is 15 W·s/cm² (ultraviolet ray strength times erase time).

This corresponds to about 15 to 20 minutes when using a UV lamp on the market (wavelength 254 nm, strength 12 mW/cm²).

Cautions 1. The programmed data contents may also be erased if the uncovered window is exposed to direct sunlight or a fluorescent light even for several hours. Thus, to protect the data contents, cover the window with an opaque film.

NEC attaches quality-tested shading film to the UV EPROM products for shipping.

2. For normal EPROM erase, the distance between the light source and the window should be 2.5 cm or less.

Remark The erase time may be prolonged if the UV lamp is old or if the device window is dirty.

5. ELECTRICAL SPECIFICATIONS

Absolute Maximum Ratings (T_a = 25 °C)

Parameter	Symbol	Conditions	Ratings	Unit
Power supply voltage	VDD		-0.3 to +7.0	V
	VLOAD		V _{DD} - 40 to V _{DD} + 0.3	V
	VPP		–0.3 to +13.5	V
Input voltage	Vi		-0.3 to VDD + 0.3	V
Output voltage	Vo	Other than display pins	-0.3 to VDD + 0.3	V
	Vod	Display pins	V _{DD} - 40 to V _{DD} + 0.3	V
High-level output	Іон	Single pin; other than display pins	-15	mA
current		Single pin; S0 - S9	-15	mA
		Single pin; T0 - T15	-30	mA
		Total of all pins other than display	-20	mA
		Total of all display pins	-120	mA
Low-level output	Iol	Single pin	17	mA
current		Total of all pins	60	mA
Operating temperature	Topt		-40 to +70	°C
Storage temperature	Tstg		-65 to +150	°C

Operating Power Supply Voltage (T_a = -40 to +70 °C)

Parameter	Conditions	MIN.	MAX.	Unit
CPU Note 1		Note 2	6.0	V
Display controller		4.5	6.0	v
Timer/pulse generator		4.5	6.0	V
Other hardwares Note 1		2.7	6.0	V

Notes 1. The CPU does not include the system clock oscillator, the display controller, or the timer/pulse generator.

2. Varies according to the cycle time. See AC Characteristics.



Resonator	Recommended constants	Parameter	Conditions	MIN.	TYP.	MAX.	Unit
Ceramic resonator	X1 X2	Note 1 Oscillation (fxx) frequency	V _{DD} = Oscillator operating voltage range	2.0		6.2	MHz
		Note 2 Oscillation stabilization time	After VDD reaches the minimum oscillator operat- ing voltage range			4	ms
Crystal resonator		Note 1 Oscillation frequency (fxx)		2.0	4.19	6.2	MHz
	│	Note 2	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$			10	ms
		Oscillation stabilization time				30	ms
External clock		Note 1 X1 input fre- quency (fx)		2.0		6.2	MHz
	mPD74HCU04	X1 input high- and low-level width (tхн, tхь)		81		250	ns

Main System Clock Configurations (Ta = -40 to +70 $^{\circ}$ C, V _{DD} = 2.7 to 6.0 V)

Subsystem Clock Configurations ($T_a = -40$ to +70 °C, V _{DD} = 2.7 to 6.0 V)

Resonator	Recommended constants	Parameter	Conditions	MIN.	TYP.	MAX.	Unit
Crystal resonator	XT1 XT2	Note 1 Oscillation frequency (fxt)		32	32.768	35	kHz
		Note 2	$V_{DD} = 4.5 \text{ to } 6.0 \text{ V}$		1.0	2	s
		Oscillation stabilization time				10	S
External clock	XT1 XT2 Open	XT1 input frequency (fxt)		32		100	kHz
	Å	XT1 input high- and low-level width (txтн, txть)		5		15	μs

- **Notes 1.** The oscillator frequency and input frequency indicate only the oscillator characteristics. Refer to the AC Characteristics for the instruction execution time.
 - 2. The oscillation stabilization time is the time required for the oscillation to stabilize after VDD is applied and reaches the VDD spec or after STOP mode is released.

Capacitance (T	a = 25 °C,	V DD = 0 V)
----------------	------------	-------------

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input capacitance		Сіл	f = 1 MHz			15	pF
Output capacitance	Other than display output	Соит	Unmeasured pins returned to 0 V			15	pF
	Display output					35	pF
Input/Output c	Input/Output capacitance					15	pF

Recommended Oscillation Circuit Constants

Main System Clock: Ceramic Resonator (T_a = -40 to +70 $^\circ\text{C})$

NA	Part number	Frequency	Capacita	ance (pF)	Oscillation	voltage (V)
Manufacturer	Part number	(MHz)	MIN.	MAX.	MIN.	MAX.
Murata	CSA×××MG	2.00 - 2.44	30	30	2.7	6.0
	CST×××MT		On-chip	On-chip	-	
	CSA×××MG093	2.45 - 3.50	30	30		
	CST×××MGW093		On-chip	On-chip		
	CSA×××MGU	2.51 - 6.00	30	30	-	
	CST×××MGWU		On-chip	On-chip		
	CSA×××MG	2.45 - 3.50	30	30	3.0	-
	CST×××MGW		On-chip	On-chip		
	CSA×××MG	2.51 - 6.00	30	30	3.3	
	CST×××MGW		On-chip	On-chip		
Kyocera	KBR – 2.0MS	2.0	47	47	2.7	6.0
	KBR – 4.0MWS	4.0	33	33		
	KBR – 4.19MWS	4.19				
	KBR – 6.0MWS	6.0				



DC Characteristics (T_a = -40 to +70 $^\circ\text{C},$ V $_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	C	onditions		MIN.	TYP.	MAX.	Unit
High-level input voltage	V _{IH1}	All except ports 0, 1, 6;	X1, X2, XT1, R	ESET	0.7V _{DD}		VDD	V
	V _{IH2}	Port 0, 1, RESET			0.75VDD		VDD	V
	Vінз	X1, X2, XT1			V _{DD} - 0.4		VDD	V
	VIH4	Port 6	V _{DD} = 4.5 to 6.0 V		0.65V _{DD}		VDD	V
					0.7V _{DD}		VDD	V
Low-level input voltage	VIL1	All except ports 0, 1, 6;	X1, X2, XT1, R	ESET	0		0.3VDD	V
	VIL2	Port 0, 1, 6, RESET			0		0.2V _{DD}	V
	VIL3	X1, X2, XT1			0		0.4	V
High-level output voltage	Vон	All outputs	V _{DD} = 4.5 to 6	.0 V, Іон = –1 mA	V _{DD} - 1.0			V
				Іон = -100 <i>µ</i> А	V _{DD} - 0.5			V
Low-level output voltage	Vol	Port 4, 5	V _{DD} = 4.5 to 6	.0 V, Io∟ = 15 mA		0.4	2.0	V
		All outputs	V _{DD} = 4.5 to 6	.0 V, IoL = 1.6 mA			0.4	V
			Ιοι = 400 μΑ				0.5	V
High-level input leakage	Ішні	All except X1, X2, XT1	$V_{\text{IN}} = V_{\text{DD}}$				3	μA
current	ILIH2	X1, X2, XT1					20	μA
Low-level input leakage		All except X1, X2, XT1	$V_{IN} = 0 V$				-3	μA
current	ILIL2	X1, X2, XT1					-20	μA
High-level output leakage current	Ігон	All outputs	Vout = Vdd				3	μA
Low-level output leakage current	ILOL1	All except display outputs	Vout = 0 V				-3	μA
	ILOL2	Display outputs	$V_{\text{OUT}} = V_{\text{LOAD}} = V_{\text{DD}} - 35 \text{ V}$				-10	μA
Display output current	Іор	S0-S9	V _{DD} = 4.5 to 6	.0 V	-3	-5.5		mA
		T0-T15	$V_{OD} = V_{DD} - 2$	V	-15	-22		mA
On-chip pull-down resistor	R∟	Display outputs	VOD - VLOAD =	35 V	25	70	135	kΩ
Note 1	IDD1	6.0 MHz crystal	$V_{DD} = 5 V \pm 10$	ე % Note 2		6.5	18.0	mA
Power supply current		oscillator	$V_{DD} = 3 V \pm 10$	ე % Note 3		0.85	2.5	mA
	IDD2		HALT mode	$V_{\text{DD}} = 5 \text{ V} \pm 10 \text{ \%}$		1350	4000	μA
				$V_{\text{DD}} = 3 \text{ V} \pm 10 \text{ \%}$		450	1350	μA
	IDD1	4.19 MHz crystal	$V_{DD} = 5 V \pm 10$	0 % Note 2		4.0	12.0	mA
		oscillator	$V_{DD} = 3 V \pm 10$	ე % Note 3		0.55	1.5	mA
	DD2	C1 = C2 = 15 pF	HALT mode	$V_{\text{DD}} = 5 \text{ V} \pm 10 \text{ \%}$		900	2700	μA
				$V_{DD} = 3 V \pm 10 \%$		300	900	μA
	Пррз	Note 4	V _{DD} = 3 V ± 10	0 %		100	300	μA
	DD4	32kHz crystal	HALT mode	$V_{\text{DD}}=3~V~\pm~10~\%$		20	60	μA
		oscillator	STOP mode	$V_{DD} = 3 V \pm 10 \%$		5	15	μA
	DD5	XT1 = 0 V	V _{DD} = 5 V ± 10	0 %		0.5	20	μA
		STOP mode	$V_{DD} = 3 V \pm 10$	0 %		0.1	10	μA

Notes 1. Does not include pull-down resistor current.

- 2. Value during high-speed operation and when the processor clock control (PCC) register is set to 0011.
- 3. Value during low-speed operation and when the PCC register is set to 0000.
- **4.** Value when the system clock control register (SCC) is set to 1001, generation of the main system clock pulse is stopped, and the CPU is operated by the subsystem clock pulse.



AC Characteristics (T_a = -40 to +70 $^\circ\text{C},$ V $_{DD}$ = 2.7 to 6.0 V)

Parameter	Symbol	Сог	nditions		MIN.	TYP.	MAX.	Unit
Note 1	tcy	Main system	V _{DD} = 4.5	to 6.0 V	0.67		32	μs
CPU clock cycle time		clock			2.6		32	μs
(minimum instruction execu- tion time = 1 machine cycle)		Subsystem clock			114	122	125	μs
TI0 input frequency	fтı	V _{DD} = 4.5 to 6.0	V		0		0.6	MHz
					0		165	kHz
TI0 input low- and high-level	tтıн,	V _{DD} = 4.5 to 6.0	V		0.83			μs
width	t⊤ı∟				3			μs
SCK cycle time	tκcγ	VDD = 4.5 to 6.0 V Input Output 0		0.8			μs	
				Output	0.95			μs
				Input	3.2			μs
				Output	3.8			μs
$\overline{\text{SCK}}$ low- and high-level width	tкн,	$V_{DD} = 4.5 \text{ to } 6.0$	V	Input	0.4			μs
	tкL			Output	tксу/2-50			ns
				Input	1.6			μs
				Output	tксу/2–150			ns
SI setup time (to SCK \uparrow)	tsıк				100			ns
SI hold time (from \overline{SCK})	tĸsi				400			ns
$\overline{\text{SCK}} \downarrow \rightarrow \text{SO}$ output delay	tκso	$V_{DD} = 4.5 \text{ to } 6.0$	V				300	ns
time				-			1000	ns
Interrupt inputs	tinth,			INT0	Note 2			μs
low- and high-level width	tintl			INT1	2tcy			μs
				INT2,4	10			μs
RESET low-level width	trsl				10			μs

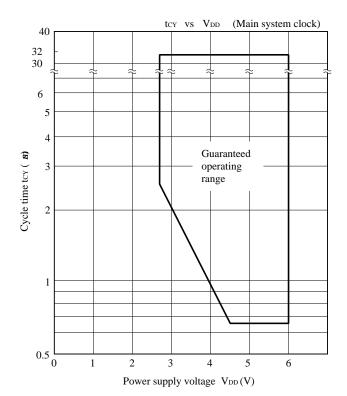
NEC

Phase-out/Discontinued

Notes 1. The CPU clock (Φ) cycle time is determined by the oscillator frequency of the connected resonator, the system clock control register (SCC), and the processor clock control register (PCC).

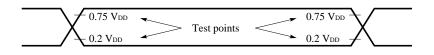
The right chart shows the cycle time tcy characteristics for power supply voltage V_{DD} during the main system clock operation.

2. 2tcy or 128/fxx, depending on the setting of the interrupt mode register (IM0).

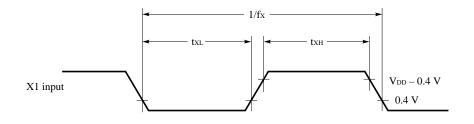


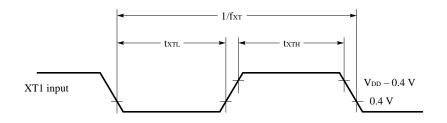
Phase-out/Discontinued

AC Timing Test Points (Except X1, XT1)

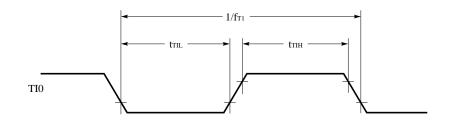


Clock Timing



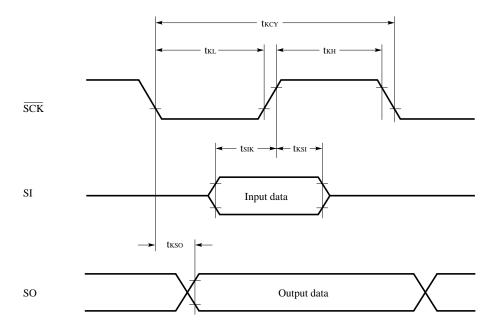


TI0 Timing

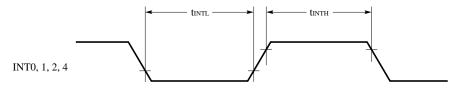


Phase-out/Discontinued

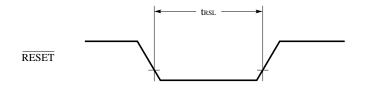
Serial Transfer Timing



Interrupt Input Timing



RESET Input Timing





Data Memory STOP Mode Low Voltage Data Retention Characteristics (T_a = -40 to +70 °C)

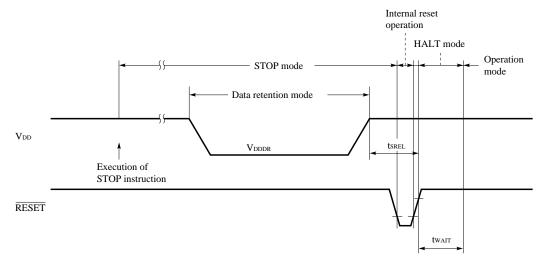
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention voltage	Vdddr		2.0		6.0	V
Data retention current Note 1	Idddr	$V_{DDDR} = 2.0 V$		0.1	10	μΑ
Release signal SET time	tsrel		0			μs
Oscillation stabilization time Note 2	twait	Release by RESET input		2 ¹⁷ /f _x		ms
		Release by interrupt request		Note 3		ms

Notes 1. Does not include pull-down resistor current.

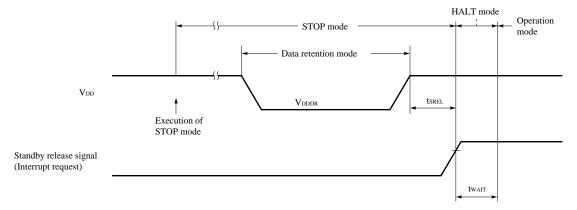
- **2.** The oscillation stabilization WAIT time is the time during which the CPU operation is stopped to prevent unstable operation while the oscillation is started.
- **3.** The WAIT time depends on the setting of the basic interval timer mode register (BTM) according to the following table.

DTMO	BTM3 BTM2 BTM1	DTM1	DTMO	WAIT time				
D I WI3	DIIVIZ	DIIVII	BTM0	(fxx = 6.0 MHz)	(fxx = 4.19 MHz)			
-	0	0	0	2 ²⁰ /fxx (approx. 175 ms)	2 ²⁰ /fxx (approx. 250 ms)			
-	0	1	1	2 ¹⁷ /fxx (approx. 21.8 ms)	2 ¹⁷ /fxx (approx. 31.3 ms)			
-	1	0	1	2 ¹⁵ /fxx (approx. 5.46 ms)	2 ¹⁵ /fxx (approx. 7.82 ms)			
-	1	1	1	2 ¹³ /fxx (approx. 1.37 ms)	2 ¹³ /fxx (approx. 1.95 ms)			

Data Retention Timing (STOP mode is released by RESET input)



Data Retention Timing (STOP mode is released by interrupt signal)



DC Programming Characteristics (T_a = 25 \pm 5 $^{\circ}C,$ V $_{DD}$ = 6.0 \pm 0.25 V, V_{PP} = 12.5 \pm 0.3 V, Vss = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
High-level input voltage	VIH1	All except X1, X2	0.7V _{DD}		Vdd	V
	VIH2	X1, X2	V _{DD} - 0.5		Vdd	V
Low-level input voltage	VIL1	All except X1, X2	0		0.3VDD	V
	VIL2	X1, X2	0		0.4	V
Input leakage current	lu	VIN = VIL or VIH			10	μA
High-level output voltage	Vон	Iон = −1 mA	Vdd - 1.0			V
Low-level output voltage	Vol	lo∟ = 1.6 mA			0.4	V
VDD power supply current	loo				30	mA
VPP power supply current	Ірр	MD0 = VIL, MD1 = VIH			30	mA

Cautions 1. VPP must not exceed +13.5 V, including overshoot.

2. VDD is to be applied prior to VPP and to be removed after VPP is removed.

AC Programming	Characteristics (T	$a = 25 \pm 5 \ ^{\circ}C, V DD =$	= 6.0 ± 0.25 V, Vpp =	12.5 ± 0.3 V, Vss = 0 V)
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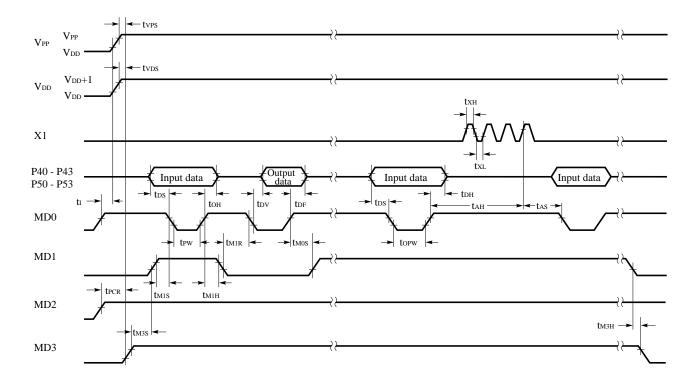
Parameter	Symbol	Note 1	Conditions	MIN.	TYP.	MAX.	Unit
Address setup time Note 2 (to MD0 \downarrow)	tas	tas		2			μs
MD1 setup time (to MD0 \downarrow)	Тм15	toes		2			μs
Data setup time (to MD0 \downarrow)	tos	tos		2			μs
Address hold time Note 2 (from MD0 1)	Тан	tан		2			μs
Data hold time (from MD0 ↑)	tон	tон		2			μs
MD0 $\uparrow ightarrow$ data output float delay time	tDF	t DF		0		130	ns
V _{PP} setup time (to MD3 ↑)	tvps	tvps		2			μs
V_{DD} setup time (to MD3 \uparrow)	tvds	tvcs		2			μs
Initialized program pulse width	tpw	tew		0.95	1.0	1.05	ms
Additional program pulse width	topw	topw		0.95		21.0	ms
MD0 setup time (to MD1 ↑)	tмos	tces		2			μs
MD0 $\downarrow \rightarrow$ data output delay time	tov	tov	MD0 = MD1 = VIL			1	μs
MD1 hold time (to MD0 ↑)	tм1н	toeh	t_{M1H} + $t_{M1R} \ge 50 \ \mu s$	2			μs
MD1 recovery time (from MD0 \downarrow)	tm₁r	tor		2			μs
Program counter reset time	t PCR	-		10			μs
X1 input low- and high-level width	txн, txL	-		0.125			μs
X1 input frequency	fx	-				4.19	MHz
Initial mode set time	tı	-		2			μs
MD3 setup time (to MD1 1)	tмзs	-		2			μs
MD3 hold time (from MD1 \downarrow)	tмзн	-		2			μs
MD3 setup time (to MD0 \downarrow)	tмзsr	-	During program read cycle	2			μs
Address $^{\text{Note 2}} \rightarrow$ Data output delay time	tdad	tacc	During program read cycle	2			μs
Address Note 2 \rightarrow Data output hold time	thad	tон	During program read cycle	0		130	ns
MD3 hold time (from MD0 ↑)	tмзнв	-	During program read cycle	2			μs
MD3 $\downarrow \rightarrow$ Data output float delay time	t dfr	-	During program read cycle	2			μs

Notes 1. These symbols correspond to those of the μ PD27C256A.

2. The internal address signal is incremented by the rising edge of the fourth X1 pulse; it is not connected to an external pin.

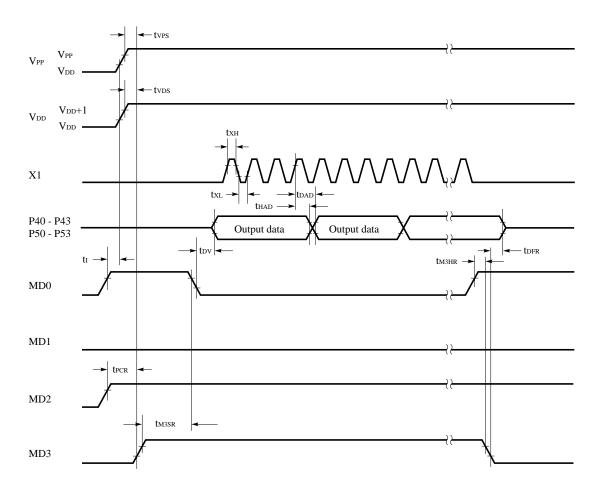
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Program Memory Write Timing



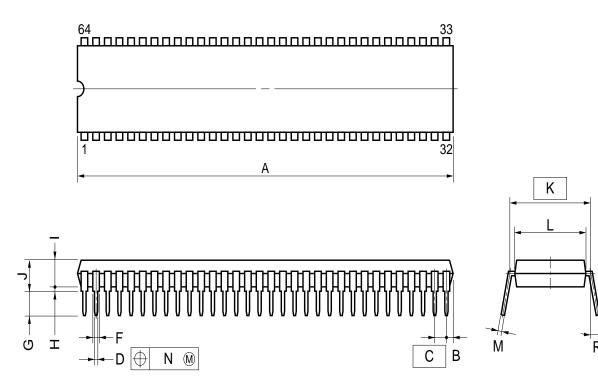
Phase-out/Discontinued

Program Memory Read Timing



6. PACKAGE DRAWINGS

64 PIN PLASTIC SHRINK DIP (750 mil)



NOTE

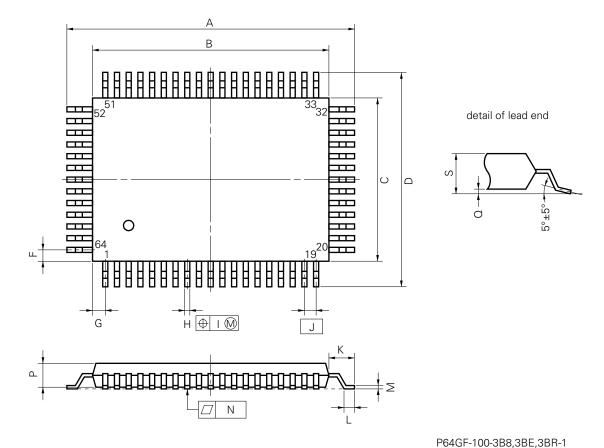
- 1) Each lead centerline is located within 0.17 mm (0.007 inch) of its true position (T.P.) at maximum material condition.
- 2) Item "K" to center of leads when formed parallel.

ITEM	MILLIMETERS	INCHES
А	58.68 MAX.	2.311 MAX.
В	1.78 MAX.	0.070 MAX.
С	1.778 (T.P.)	0.070 (T.P.)
D	0.50±0.10 0.020 ^{+0.004}	
F	0.9 MIN.	0.035 MIN.
G	3.2±0.3	0.126±0.012
Н	0.51 MIN.	0.020 MIN.
Ι	4.31 MAX.	0.170 MAX.
J	5.08 MAX.	0.200 MAX.
Κ	19.05 (T.P.)	0.750 (T.P.)
L	17.0	0.669
М	$0.25^{+0.10}_{-0.05}$	$0.010^{+0.004}_{-0.003}$
Ν	0.17	0.007
R	0~15°	0~15°

P64C-70-750A,C-1

Phase-out/Discontinued

64 PIN PLASTIC QFP (14×20)



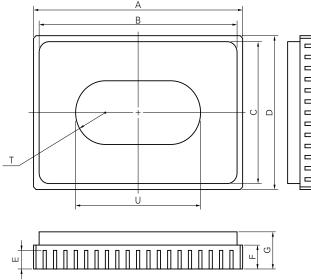
NOTE

Each lead centerline is located within 0.20 mm (0.008 inch) of its true position (T.P.) at maximum material condition.

ITEM	MILLIMETERS	INCHES
A	23.6±0.4	0.929±0.016
В	20.0±0.2	0.795 ^{+0.009} _0.008
С	14.0±0.2	$0.551^{+0.009}_{-0.008}$
D	17.6±0.4	0.693±0.016
F	1.0	0.039
G	1.0	0.039
Н	0.40±0.10	$0.016\substack{+0.004\\-0.005}$
I	0.20	0.008
J	1.0 (T.P.)	0.039 (T.P.)
К	1.8±0.2	$0.071^{+0.008}_{-0.009}$
L	0.8±0.2	$0.031^{+0.009}_{-0.008}$
М	$0.15\substack{+0.10 \\ -0.05}$	$0.006^{+0.004}_{-0.003}$
N	0.12	0.005
Р	2.7	0.106
Q	0.1±0.1	0.004±0.004
S	3.0 MAX.	0.119 MAX.

Phase-out/Discontinued

64 PIN CERAMIC WQFN



NOTE

Each lead centerline is located within 0.10 mm (0.004 inch) of its true position (T.P.) at maximum material condition.

-K-

X64KW-100A-2 ITEM MILLIMETERS INCHES 0.787^{+0.017}_{-0.016} А 20.0±0.4 0.748 В 19.0 С 13.2 0.520 D 14.0±0.4 0.551 ± 0.016 Е 1.64 0.065 F 2.14 0.084 0.140 MAX. G 3.556 MAX. 0.028+0.004 Н 0.7±0.10 0.004 Ι 0.10 J 1.0 (T.P.) 0.039 (T.P.) $0.039\substack{+0.009\\-0.008}$ 1.0±0.2 Κ C 0.010 Q C 0.25 R 1.0 0.039 S 1.0 0.039 Т R 0.118 R 3.0 U 0.472 12.0 $0.031^{+0.009}_{-0.008}$ W 0.8±0.2

7. RECOMMENDED SOLDERING CONDITIONS

The following conditions (See table below) must be met when soldering this product.

Please consult with our sales offices in case other soldering process is used, or in case soldering is done under different conditions.

For more details, refer to our document "SEMICONDUCTOR DEVICE MOUNTING TECHNOLOGY MANUAL" (IEI-1207).

TYPE OF SURFACE MOUNT DEVICE

μ PD75P218GF-3BR

Soldering Process	Soldering Conditions	Symbol
Wave Soldering	Solder temperature: 260 °C or lower, Flow time: 10 seconds or less, Exposure limit ^{Note} : 7 days (10 hour pre-baking is required at 125 °C afterwards) Number of flow processes: 1	WS60-107-1
Infrared Ray Reflow	Peak temperature of package surface: 230 °C or lower Reflow time: 30 seconds or less (210 °C or higher), Number of reflow processes: 1 Exposure limit ^{Note} : 7 days (10 hour pre-baking is required at 125 °C afterwards)	IR30-107-1
VPS	Peak temperature of package surface: 215 °C or lower Reflow time: 40 seconds or less (200 °C or higher), Number of reflow processes: 1 Exposure limit ^{Note} : 7 days (10 hour pre-baking is required at 125 °C afterwards)	VP15-107-1
Partial Heating Method	Pin temperature: 300 °C or lower, Time: 3 seconds or less (Per side of the package)	-

Note Exposure limit before soldering after dry-pack package is opened. Storage conditions: 25 °C and relative humidity at 65 % or less.

Caution Do not apply more than one soldering method at any one time, except for "Partial heating method".

TYPE OF THROUGH HOLE DEVICE

μ**PD75P218CW**

Soldering Process	Soldering Conditions		
Wave Soldering	Solder temperature: 260 °C or lower,		
(only lead part)	Flow time: 10 seconds or less		
Partial Heating	Pin temperature: 260 °C or lower,		
Method	Time: 10 seconds or less		

Caution This wave soldering should be applied only to lead part, and do not jet molten solder on the surface of package.



APPENDIX DEVELOPMENT TOOLS

The following development tools are provided for the development of a system which employs the μ PD75P218.

Language processor

RA75X relocatable assembler	This program converts symbolic source code for the μ PD75000 series of microcomputers into executable absolute address object code.			
	There are also functions such as generating a symbol table a			
	branch instructions automatically.			
	Host machine			
	HOSt machine	OS	Distribution media	- Part number
	PC-9800 series	MS-DOS™ ∕Ver. 3.10 ∖	3.5-inch 2HD	μS5A13RA75X
		to Ver. 3.30C	5-inch 2HD	μS5A10RA75X
	IBM PC series	PC DOS™ (Ver. 3.1)	5-inch 2HC	μS7B10RA75X

PROM programming tools

Hardware	PG-1500	The PG-1500 PROM programmer is used together with an accessory board				
		and optional program adapter. It allows the user to program a single chip				
		microcomputer containing PROM and typical 256K-bit to 1M-bit PROMs				
		from a keyboard				
1	PA-75P216ACW	PROM programmer adapter dedicated to μ PD75P218CW. Connect the programmer adapter to PG-1500 for use.				
	PA-75P218GF	PROM programmer adapter dedicated to μ PD75P218GF.				
		Connect the programmer adapter to PG-1500 for use.				
	PA-75P218KB	PROM programm				
		Connect the prog				
Software	PG-1500 controller	This program enables the host machine to control the PG-1500 through the serial and parallel interfaces.				
1		Host machine	OS	Distribution media	Part number	
		PC-9800 series	MS-DOS / Ver. 3.10 \	3.5-inch 2HD	μS5A13PG1500	
			ver. 3.30C	5-inch 2HD	μS5A10PG1500	
		IBM PC series	PC DOS (Ver. 3.1)	5-inch 2HC	μS7B10PG1500	

Debugging tools

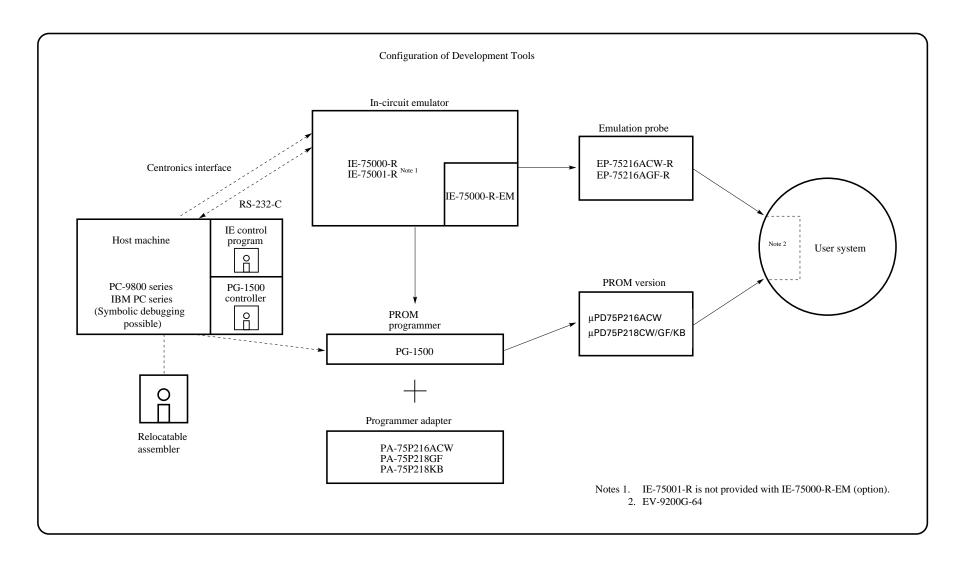
r						
Hardware	IE-75000-R Note 1	The IE-75000-R is an in-circuit emulator available for the 75X series. This emulator is used together with the emulation probe to develop application systems of the μ PD75P218. For efficient debugging, the emula- tor is connected to the host machine and PROM programmer.				
	IE-75000-R-EM Note 2	The IE-75000-R-EM is an emulation board for the IE-75000-R and IE-75001-R. The IE-75000-R contains the emulation board. The emulation board is used together with the IE-75000-R or IE75001-R to evaluate the μ PD75P218.				
IE-75001-R		The IE-75001-R is an in-circuit emulator available for the 75X series. This emulator is used together with the IE-75000-R-EM ^{Note 2} emulation board and emulation probe to develop application systems of the μ PD75P218. For efficient debugging, the emulator is connected to the host machine and PROM programmer.				
	EP-75216ACW-R	Emulation probe for the μ PD75P218CW. Connect this probe to the IE-75000-R or IE-75001-R for use.				
	EP-75216AGF-R	Emulation probe for the μ PD75P218GF. Connect this probe to the IE-75000-R or IE-75001-R for use. A 64-pin conversion socket, the EV-9200G-64, attached to the probe				
	EV-9200G-64	facilitates the connection of the probe with the user system.				
Software	IE control program			hine to control the IE-7 ough the RS-232-C inte		
		Host machine	OS	Distribution media	Part number	
		PC-9800 series	MS-DOS / Ver. 3.10 \	3.5-inch 2HD	μS5A13IE75X	
			(to Ver. 3.30C	5-inch 2HD	μS5A10IE75X	
		IBM PC series	PC DOS (Ver. 3.1)	5-inch 2HC	μS7B10IE75X	

Phase-out/Discontinued

Notes 1. Provided only for maintenance purposes.

- 2. The IE-75000-R-EM is an option.
- **Remark** NEC is not responsible for the operation of the IE control program and assembler unless it runs on any host machine with the operation system listed above.

Phase-out/Discontinued



NEC

Phase-out/Discontinued

[MEMO]

NOTES FOR CMOS DEVICES

(1) PRECAUTION AGAINST ESD FOR SEMICONDUCTORS

Note:

Strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred. Environmental control must be adequate. When it is dry, humidifier should be used. It is recommended to avoid using insulators that easily build static electricity. Semiconductor devices must be stored and transported in an antistatic container, static shielding bag or conductive material. All test and measurement tools including work bench and floor should be grounded. The operator should be grounded using wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with semiconductor devices on it.

(2) HANDLING OF UNUSED INPUT PINS FOR CMOS

Note:

No connection for CMOS device inputs can be cause of malfunction. If no connection is provided to the input pins, it is possible that an internal input level may be generated due to noise, etc., hence causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using a pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND with a resistor, if it is considered to have a possibility of being an output pin. All handling related to the unused pins must be judged device by device and related specifications governing the devices.

(3) STATUS BEFORE INITIALIZATION OF MOS DEVICES

Note:

Power-on does not necessarily define initial status of MOS device. Production process of MOS does not define the initial operation status of the device. Immediately after the power source is turned ON, the devices with reset function have not yet been initialized. Hence, power-on does not guarantee out-pin levels, I/O settings or contents of registers. Device is not initialized until the reset signal is received. Reset operation must be executed immediately after power-on for devices having reset function. No part of this document may be copied or reproduced in any form or by any means without the prior written consent of NEC Corporation. NEC Corporation assumes no responsibility for any errors which may appear in this document.

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The devices listed in this document are not suitable for use in aerospace equipment, submarine cables, nuclear reactor control systems and life support systems. If customers intend to use NEC devices for above applications or they intend to use "Standard" quality grade NEC devices for applications not intended by NEC, please contact our sales people in advance.

Application examples recommended by NEC Corporation

Standard: Computer, Office equipment, Communication equipment, Test and Measurement equipment, Machine tools, Industrial robots, Audio and Visual equipment, Other consumer products, etc.

Special: Automotive and Transportation equipment, Traffic control systems, Antidisaster systems, Anticrime systems, etc.

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